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KEY=ON - LAMBERT LORELAI

Advances in Precision Instruments and Optical Engineering

Proceedings of the International Conference on Precision Instruments and Optical Engineering, 2021

Springer Nature

Advances in Network-Based Information Systems

The 25th International Conference on Network-Based Information Systems (NBIS-2022)

Springer Nature The networks and information systems of today are evolving rapidly. There are new trends and applications in information networking such as wireless sensor networks, ad hoc networks, peer-to-peer systems, vehicular networks, opportunistic networks, grid and cloud computing, pervasive and ubiquitous computing, multimedia systems, security, multi-agent systems, high-speed networks, and web-based systems. These kinds of networks need to manage the increasing number of users, provide support for different services, guarantee the QoS, and optimize the network resources. For these networks, there are many research issues and challenges that should be considered and find solutions. The aim of the book "Advances in Network-Based Information Systems" is to provide latest research findings, innovative research results, methods, and development techniques from both theoretical and practical perspectives related to the emerging areas of information networking and their applications.

Encyclopedia of Artificial Intelligence

IGI Global "This book is a comprehensive and in-depth reference to the most recent developments in the field covering theoretical developments, techniques, technologies, among others"--Provided by publisher.

Postdoctoral Research Associateships

Opportunities for Research at the U.S. Department of Commerce, National Bureau of Standards ... in Association with the National Research Council

NASA Patent Abstracts Bibliography

Measurement Technology and Intelligent Instruments VI

Trans Tech Publications Ltd The requirements of high precision and of high-quality components and devices in meeting the needs of modern industry and society in disciplines such as semiconductors, optics, nanotechnology, MEMS, manufacturing, biomedical and environmental engineering, make measurement technology and intelligent instruments (which sense, measure and report), more important than ever, and essential for the rapid development of information technology. Following the lead of the previous five publications (1989, 1993, 1996, 1998, 2001) in the series, [Measurement Technology and Intelligent Instruments], this book presents the most recent advances in this important field. In all, 123 papers were contributed from many regions of the world: including China, Taiwan (China), Japan, Russia, Hong Kong (China), Germany, Australia, Austria, Canada, Korea, Poland, Slovakia and the UK and US.

Intelligent Equipment, Robots, and Vehicles

Springer Nature

Electromagnetic Aquametry

Electromagnetic Wave Interaction with Water and Moist Substances

Springer Science & Business Media Information about a material can be gathered from its interaction with electromagnetic waves. The information may be stored in the amplitude, the phase, the polarisation, the angular distribution of energy transportation or the spectral characteristics. When retrieved from the wave, certain material properties may thus be determined indirectly. Compared on the one hand to direct material analysis, an indirect method requires calibration and is prone to interference from undesired sources. On the other hand, however, it permits the determination of features inaccessible by direct methods, such as non-destructive material interrogation, high measurement speed, or deep penetration depth. However, being a physical method, the use of electromagnetic waves is still handicapped by the lack of acceptance by many chemists, who are used to applying direct approaches. Historically, the first application of electromagnetic wave interaction with matter involved measurement of amplitude changes at a single frequency caused by material properties, and it is still used today by some systems. This approach was soon supplemented by single frequency phase measurements, in order to avoid distortions through amplitude instabilities or parasitic reflections. Such single parameter measurements of course require dependence only on one variable in the measured process and sufficient stability of all other ancillary conditions. If that is not the case, the single parameter measurement fails.

Case Studies in Bayesian Statistics

Springer Science & Business Media The past few years have witnessed dramatic advances in computational methods for Bayesian inference. As a result, Bayesian approaches to solving a wide variety of problems in data analysis and decision-making have become feasible, and there is currently a growth spurt in the application of Bayesian methods. The purpose of this volume is to present several detailed examples of applications of Bayesian thinking, with an emphasis on the scientific or technological context of the problem being solved. The papers collected here were presented and discussed at a Workshop held at Carnegie-Mellon University, September 29 through October 1, 1991. There are five major articles, each with two discussion pieces and a reply. These articles were invited by us following a public solicitation of abstracts. The problems they address are diverse, but all bear on policy decision-making. Though not part of our original design for the Workshop, that commonality of theme does emphasize the usefulness of Bayesian methods in this arena. Along with the invited papers were several additional commentaries of a general nature; the first comment was invited and the remainder grew out of the discussion at the Workshop. In addition there are nine contributed papers, selected from the thirty-four presented at the Workshop, on a variety of applications. This collection of case studies illustrates the ways in which Bayesian methods are being incorporated into statistical practice. The strengths (and limitations) of the approach become apparent through the examples.

Guide to State-of-the-Art Electron Devices

John Wiley & Sons Winner, 2013 PROSE Award, Engineering and Technology Concise, high quality and comparative overview of state-of-the-art electron device development, manufacturing technologies and applications Guide to State-of-the-Art Electron Devices marks the 60th anniversary of the IRE electron devices committee and the 35th anniversary of the IEEE Electron Devices Society, as such it defines the state-of-the-art of electron devices, as well as future directions across the entire field. Spans full range of electron device types such as photovoltaic devices, semiconductor manufacturing and VLSI technology and circuits, covered by IEEE Electron and Devices Society Contributed by internationally respected members of the electron devices community A timely desk reference with fully-integrated colour and a unique lay-out with sidebars to highlight the key terms Discusses the historical developments and speculates on future trends to give a more rounded picture of the topics covered A valuable resource R&D managers; engineers in the semiconductor industry; applied scientists; circuit designers; Masters students in power electronics; and members of the IEEE Electron Device Society.

Integrated Optical Devices

Fabrication and Testing : 30 October-1 November 2002, Brugge, Belgium

Society of Photo Optical

International Workshop on New Approaches to High-Tech Materials, Nondestructive Testing and Computer Simulations in Materials Science and Engineering

Handbook of Nitride Semiconductors and Devices, GaN-based Optical and Electronic Devices

John Wiley & Sons The three volumes of this handbook treat the fundamentals, technology and nanotechnology of nitride semiconductors with an extraordinary clarity and depth. They present all the necessary basics of semiconductor and device physics and engineering together with an extensive reference section. Volume 3 deals with nitride semiconductor devices and device technology. Among the application areas that feature prominently here are LEDs, lasers, FETs and HBTs, detectors and unique issues surrounding solar blind detection.

Metal Fatigue Damage

Mechanism, Detection, Avoidance, and Repair

ASTM International

Optical Techniques for Industrial Inspection

This book presents an extensive review of the optical- and laser-based techniques that are available for quality control and process monitoring in the industrial production environment. The physical principles of each technique are explained in simple terms, and their applicability to specific industrial needs is discussed on the basis of wide hands-on experience. A large number of practical applications to in-process industrial sensing and metrology are described, and more than onethousand references are included. Topics include on-line surface inspection, 3-D imaging, nondestructive testing, fiber-optic sensors, robot guidance, as well as spectroscopic and light-scattering process analyzers. Key Features * Describes a large number of practical applications to in-process industrial sensing and metrology * Includes more than one thousand references * Covers on-line surface inspection, 3-D imaging, nondestructive testing, fiber-optic sensors, robot guidance, and more

Semiconductor Device-Based Sensors for Gas, Chemical, and Biomedical Applications

CRC Press Sales of U.S. chemical sensors represent the largest segment of the multi-billion-dollar global sensor market, which includes instruments for chemical detection in gases and liquids, biosensors, and medical sensors. Although silicon-based devices have dominated the field, they are limited by their general inability to operate in harsh environments

Subsurface Defect Detection in Ceramic Materials Using Low Coherence Optical Scatter Reflectometer

We demonstrate the use of optical gating techniques for determining the size and location of subsurface defects in advanced ceramic materials. Various silicon nitride based ceramic materials are probed non-destructively using an optical gated reflectometer based on a low-coherence fiber interferometer. This device is capable of depth and lateral resolutions of 10 micrometers and 4 micrometers, respectively. Experimental results indicate that the size and position of small subsurface defects can be determined as deep as 500 micrometers below the surface.

Scientific and Technical Aerospace Reports

Lists citations with abstracts for aerospace related reports obtained from world wide sources and announces documents that have recently been entered into the NASA Scientific and Technical Information Database.

Advances in Intelligent Systems and Interactive Applications

Proceedings of the 2nd International Conference on Intelligent and Interactive Systems and Applications (IISA2017)

Springer This book presents research papers from diverse areas on novel Intelligent Systems and Interactive Systems and Applications. It gathers selected research papers presented at the 2nd International Conference on Intelligent and Interactive Systems and Applications (IISA2017), which was held on June 17-18, 2017 in Beijing, China. Interactive Intelligent Systems (IIS) are systems that interact with human beings, media or virtual agents in intelligent computing environments. The emergence of Big Data and the Internet of Things have now opened new opportunities in both academic and industrial research for the successful design and development of intelligent interactive systems. This book explores how novel interactive systems can be used to overcome various challenges and limitations previously encountered by human beings by combining machine learning algorithms and the analysis of recent trends. The book presents 125 contributions, which have been categorized into seven sections, namely: i) Autonomous Systems; ii) Pattern Recognition and Vision Systems; iii) E-Enabled Systems; iv) Mobile Computing and Intelligent Networking; v) Internet and Cloud Computing; vi) Intelligent Systems, and vii) Various Applications. It not only offers readers extensive theoretical information on Intelligent and Interactive Systems, but also introduces them to various applications in different domains.

Advanced Hybrid Information Processing

4th EAI International Conference, ADHIP 2020, Binzhou, China, September 26-27, 2020, Proceedings, Part II

Springer Nature This two-volume set constitutes the post-conference proceedings of the 4th EAI International Conference on Advanced Hybrid Information Processing, ADHIP 2020, held in Binzhou, China, in September 2020. Due to COVID-19 the conference was held virtually. The 89 papers presented were selected from 190 submissions and focus on theory and application of hybrid information processing technology for smarter and more effective research and application. The theme of ADHIP 2020 was "Industrial applications of aspects with big data". The papers are named in topical sections as follows: Industrial application of multi-modal information processing; Industrialized big data processing; Industrial automation and intelligent control; Visual information processing.

The Soviet Journal of Nondestructive Testing

Measurement, Modeling and Automation in Advanced Food Processing

Springer This book review series presents current trends in modern biotechnology. The aim is to cover all aspects of this interdisciplinary technology where knowledge, methods and expertise are required from chemistry, biochemistry, microbiology, genetics, chemical engineering and computer science. Volumes are organized topically and provide a comprehensive discussion of developments in the respective field over the past 3-5 years. The series also discusses new discoveries and applications. Special volumes are dedicated to selected topics which focus on new biotechnological products and new processes for their synthesis and purification. In general, special volumes are edited by well-known guest editors. The series editor and publisher will however always be pleased to receive suggestions and supplementary information. Manuscripts are accepted in English.

The Compact Disc Handbook

A-R Editions, Inc. Revision of the 1989 book The compact disk: a handbook of theory and use. A technical discussion of the system. Annotation copyrighted by Book News, Inc., Portland, OR

Leading Edge Nanotechnology Research Developments

Nova Publishers Nanotechnology is a 'catch-all' description of activities at the level of atoms and molecules that have applications in the real world. A nanometer is a billionth of a meter, about 1/80,000 of the diameter of a human hair, or 10 times the diameter of a hydrogen atom. Nanotechnology is now used in precision engineering, new materials development as well as in electronics; electromechanical systems as well as mainstream biomedical applications in areas such as gene therapy, drug delivery and novel drug discovery techniques. This book present simportant breakthroughs in the field from around the world.

International Journal of Materials & Product Technology

Official Gazette of the United States Patent and Trademark Office

Patents

Electronic Materials Handbook

Packaging

ASM International Volume 1: Packaging is an authoritative reference source of practical information for the design or process engineer who must make informed day-to-day decisions about the materials and processes of microelectronic packaging. Its 117 articles offer the collective knowledge, wisdom, and judgement of 407 microelectronics packaging experts-authors, co-authors, and reviewers-representing 192 companies, universities, laboratories, and other organizations. This is the inaugural volume of ASM's all-new Electronic Materials Handbook series, designed to be the Metals Handbook of electronics technology. In over 65 years of publishing the Metals Handbook, ASM has developed a unique editorial method of compiling large technical reference books. ASM's access to leading materials technology experts enables to organize these books on an industry consensus basis. Behind every article, is an author who is a top expert in its specific subject area. This multi-author approach ensures the best, most timely information throughout. Individually selected panels of 5 and 6 peers review each article for technical accuracy, generic point of view, and completeness. Volumes in the Electronic Materials Handbook series are multidisciplinary, to reflect industry practice applied in integrating multiple technology disciplines necessary to any program in advanced electronics. Volume 1: Packaging focusing on the middle level of the electronics technology size spectrum, offers the greatest practical value to the largest and broadest group of users. Future volumes in the series will address topics on larger (integrated electronic assemblies) and smaller (semiconductor materials and devices) size levels.

Electronics and Signal Processing

Frontiers Media SA

Optical Methods in Engineering Metrology

Springer Science & Business Media Optical methods, stimulated by the advent of inexpensive and reliable lasers, are assuming an increasingly important role in the field of engineering metrology. Requiring only a basic knowledge of optics, this text provides a compendium of practical information prepared by leaders in the field.

Advances in Automation, Signal Processing, Instrumentation, and Control

Select Proceedings of i-CASIC 2020

Springer Nature This book presents the select proceedings of the International Conference on Automation, Signal Processing, Instrumentation and Control (i-CASIC) 2020. The book mainly focuses on emerging technologies in electrical systems, IoT-based instrumentation, advanced industrial automation, and advanced image and signal processing. It also includes studies on the analysis, design and implementation of instrumentation systems, and high-accuracy and energy-efficient controllers. The contents of this book will be useful for beginners, researchers as well as professionals interested in instrumentation and control, and other allied fields.

Optical Test and Measurement Technology and Equipment

2nd International Symposium on Advanced Optical Manufacturing and Testing Technologies : 2-5 November, 2005, Xian, China

SPIE-International Society for Optical Engineering Proceedings of SPIE present the original research papers presented at SPIE conferences and other high-quality conferences in the broad-ranging fields of optics and photonics. These books provide prompt access to the latest innovations in research and technology in their respective fields. Proceedings of SPIE are among the most cited references in patent literature.

Automated Photomask Inspection

NBS Special Publication

Reliability Abstracts and Technical Reviews

Official Gazette of the United States Patent and Trademark Office

Patents

Physics (Group 1)

S. Chand Publishing S. Chand's Physics, designed to serve as a textbook for students pursuing their engineering degree course, B.E. in Gujarat Technical University. The book is written with the singular objective of providing the students of GTU with a distinct source material as per the syllabus. The philosophy of presentation of the material in the book is based upon decades of classroom interaction of the authors. In each chapter, the fundamental concepts pertinent to the topic are highlighted and the in-between continuity is emphasized. Throughout the book attention is given to the proper

presentation of concepts and practical applications are cited to highlight the engineering aspects. A number of problems are solved. New problems are included in order to expedite the learning process of students of all hues and to improve their academic performance. The fundamental concepts are emphasized in each chapter and the details are developed in an easy-to-follow style. Each chapter is divided into smaller parts and sub-headings are provided to make the reading a pleasant journey from one interesting topic to another important topic.

Railroad Safety

Hearing Before the Subcommittee on Surface Transportation and Merchant Marine of the Committee on Commerce, Science, and Transportation, United States Senate, One Hundred Seventh Congress, Second Session, July 10, 2002

Forest Products Journal

Nondestructive Testing in Composite Materials

MDPI In this era of technological progress and given the need for welfare and safety, everything that is manufactured and maintained must comply with such needs. We would all like to live in a safe house that will not collapse on us. We would all like to walk on a safe road and never see a chasm open in front of us. We would all like to cross a bridge and reach the other side safely. We all would like to feel safe and secure when taking a plane, ship, train, or using any equipment. All this may be possible with the adoption of adequate manufacturing processes, with non-destructive inspection of final parts and monitoring during the in-service life of components. Above all, maintenance should be imperative. This requires effective non-destructive testing techniques and procedures. This Special Issue is a collection of some of the latest research in these areas, aiming to highlight new ideas and ways to deal with challenging issues worldwide. Different types of materials and structures are considered, different non-destructive testing techniques are employed with new approaches for data treatment proposed as well as numerical simulations. This can serve as food for thought for the community involved in the inspection of materials and structures as well as condition monitoring.

Index Aeronauticus

A Review of Technical Information